

Search Notes

Application/Control No.

10/719,743

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

NEW ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	147-150, 152,159, 161,237	5/13/2005	HLN
	242-245		
	261,262		
	269,270		
	276,284		
↓	294,295	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	5/13/2005	HLN
EAST Text Search: (delay WITH (memory ADJ cell))	—	—

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner